SN64BCT240 OCTAL BUFFER/DRIVER WITH 3-STATE OUTPUTS SCBS049A – MAY 1990 – REVISED NOVEMBER 1993

 State-of-the-Art BiCMOS Design Significantly Reduces I_{CCZ} 	DW OR N PACKAGE (TOP VIEW)
 3-State Outputs Drive Bus Lines or Buffer-Memory Address Registers 	$1 \overline{OE} \begin{bmatrix} 1 & 20 \end{bmatrix} V_{\underline{CC}}$ $1 \overline{A1} \begin{bmatrix} 2 & 19 \end{bmatrix} 2 \overline{OE}$
 ESD Protection Exceeds 2000 V Per MIL-STD-883C Method 3015 	1A1 [] 2 19 [] 2OE 2Y4 [] 3 18 [] 1Y1 1A2 [] 4 17 [] 2A4
 High-Impedance State During Power-Up and Power-Down 	2Y3 [5 16] 1Y2 1A3 [6 15] 2A3
 Package Options Include Plastic Small-Outline (DW) Packages and Standard 	2Y2 [] 7 14 [] 1Y3 1A4 [] 8 13 [] 2A2
Plastic 300-mil DIPs (N)	2Y1 [9 12] 1Y4 GND [10 11] 2A1

description

This octal buffer and line driver is designed specifically to improve both the performance and density of 3-state memory address drivers, clock drivers, and bus-oriented receivers and transmitters. Taken together with the SN64BCT241 and SN64BCT244, these devices provide the choice of selected combinations of inverting and noninverting outputs, symmetrical active-low output-enable (OE) inputs, and complementary OE and OE inputs.

The SN64BCT240 is organized as two 4-bit buffers/line drivers with separate output-enable (\overline{OE}) inputs. When \overline{OE} is low, the device passes data from the A inputs to the Y outputs. When \overline{OE} is high, the outputs are in the high-impedance state.

The SN64BCT240 is characterized for operation from -40°C to 85°C and 0°C to 70°C.

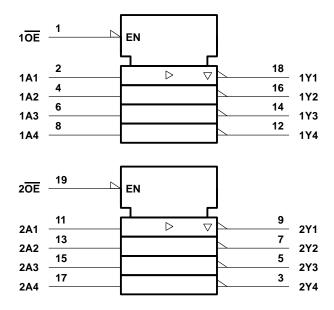
FUNCTION TABLE (each buffer)						
INP	JTS	OUTPUT				
OE	Α	Y				
L	Н	L				
L	L	Н				
Н	Х	Z				



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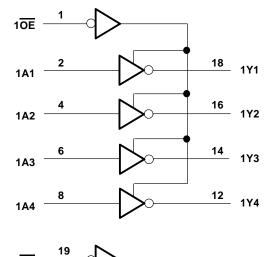
SCBS049A - MAY 1990 - REVISED NOVEMBER 1993

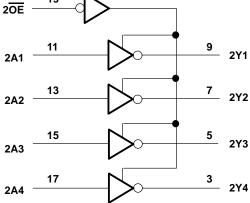
logic symbol[†]



[†] This symbol is in accordance with ANSI/IEEE Std 91-1984 and IEC Publication 617-12.

logic diagram (positive logic)





absolute maximum ratings over operating free-air temperature range (unless otherwise noted)[‡]

Supply voltage range, V _{CC}	– 0.5 V to 7 V
Input voltage range, V _I (see Note 1)	– 0.5 V to 7 V
Voltage range applied to any output in the disabled or power-off state, VO	– 0.5 V to 5.5 V
Voltage range applied to any output in the high state, VO	-0.5 V to V _{CC}
Current into any output in the low state	128 mA
Operating free-air temperature range	. − 40°C to 85°C
Storage temperature range	– 65°C to 150°C

[‡] Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

NOTE 1: The input negative voltage rating may be exceeded if the input clamp current rating is observed.



recommended operating conditions

		MIN	NOM	MAX	UNIT
VCC	Supply voltage	4.5	5	5.5	V
VIH	High-level input voltage	2			V
VIL	Low-level input voltage			0.8	V
IIK	Input clamp current			-18	mA
IOH	High-level output current			-15	mA
IOL	Low-level output current			64	mA
TA	Operating free-air temperature	-40		85	°C

electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

PARAMETER	TES	T CONDITIONS	MIN	TYP†	MAX	UNIT
VIK	V _{CC} = 4.5 V,	Ij = -18 mA			-1.2	V
	V _{CC} = 4.5 V	$I_{OH} = -3 \text{ mA}$	2.4	3.3		
VOH		I _{OH} = -15 mA	2	3.1		V
	V _{CC} = 4.75 V,	$I_{OH} = -3 \text{ mA}$	2.7			
VOL	V _{CC} = 4.5 V,	I _{OH} = 64 mA		0.42	0.55	V
IOZH	V _{CC} = 5.5 V,	$V_{O} = 2.7 V$			50	μΑ
IOZL	V _{CC} = 5.5 V,	$V_{O} = 0.5 V$			-50	μΑ
107	$V_{CC} = 0$ to 2.3 V (power up)	$V_{O} = 2.7 \text{ V or } 0.5 \text{ V}, \qquad \overline{\text{OE}} \text{ at } 0.8 \text{ V}$			± 50	μA
loz	V_{CC} = 1.8 V to 0 (power down)	$V_0 = 2.7$ V or 0.3 V, OE at 0.8 V			± 50	μΑ
lj	V _{CC} = 5.5 V,	$V_{I} = 7 V$			0.1	mA
ЧΗ	V _{CC} = 5.5 V,	V _I = 2.7 V			20	μΑ
կլ	V _{CC} = 5.5 V,	V _I = 0.5 V			-1	mA
los‡	V _{CC} = 5.5 V,	$V_{O} = 0$	-100		-225	mA
ICCL	V _{CC} = 5.5 V			19	31	mA
ІССН	$V_{CC} = 5.5 V$			46	71	mA
ICCZ	$V_{CC} = 5.5 V$			6	9	mA
Ci	V _{CC} = 5 V,	V _I = 2.5 V or 0.5 V		6		pF
Co	V _{CC} = 5 V,	$V_{O} = 2.5 V \text{ or } 0.5 V$		11		pF

[†] All typical values are at $V_{CC} = 5 \text{ V}$, $T_A = 25^{\circ}\text{C}$. [‡] Not more than one output should be tested at a time, and the duration of the test should not exceed one second.



SN64BCT240 **OCTAL BUFFER/DRIVER** WITH 3-STATE OUTPUTS SCBS049A – MAY 1990 – REVISED NOVEMBER 1993

switching characteristics (see Note 2)

PARAMETER	FROM (INPUT)	ТО (О U ТРUТ)	V _{CC} = 5 V, C _L = 50 pF, R1 = 500 Ω, R2 = 500 Ω, T _A = 25°C		CL R1	c = 4.5 \ = 50 pF, = 500 Ω = 500 Ω	,	Ι,	UNIT				
		(001201)					$()^{-1}$		$T_{A} = 25^{\circ}C T_{A} = -40^{\circ}C T_{A} =$			$T_A = 25^{\circ}C$ $T_A = -40^{\circ}C$	
			MIN	MAX	MIN	MAX	MIN	MAX					
^t PLH	A	Y	0.5	4.8	0.5	6.4	0.5	5.6	ns				
^t PHL		~	I	0.4	3.5	0.4	4.5	0.4	4	115			
^t PZH	ŌĒ	Y	1	7.9	1	9.2	1	8.8	ns				
^t PZL		I	1	9.4	1	10.8	1	10.5	115				
^t PHZ	ŌĒ	Y	1	6.8	1	8.5	1	8.1	200				
^t PLZ	UE		1	8.1	1	10.6	1	9.5	ns				

NOTE 2: Load circuits and voltage waveforms are shown in Section 1.



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